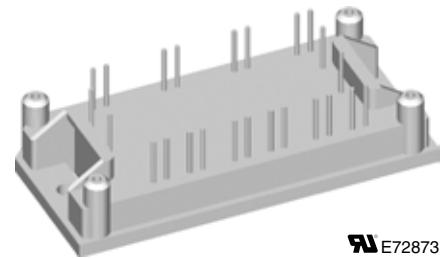
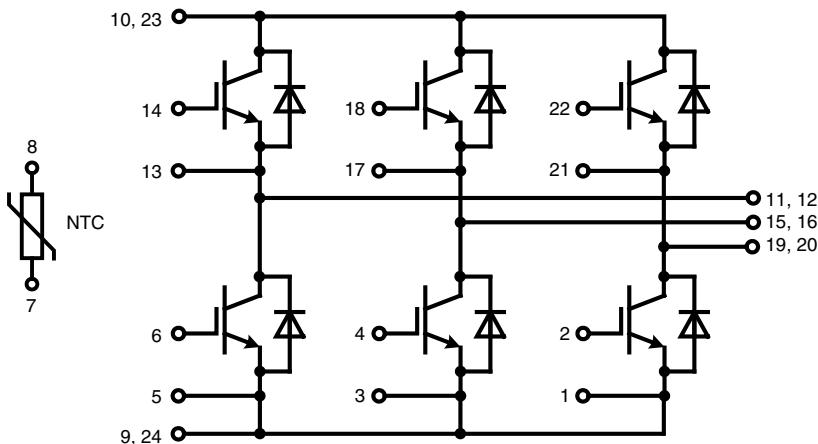


Six-Pack XPT IGBT

V_{CES} = 1200 V
 I_{C25} = 17 A
 $V_{CE(sat)}$ = 1.8 V

Part name (Marking on product)

MIXA10W1200TML



E72873

Pin configuration see outlines.

Features:

- High level of integration
- Rugged XPT design
(Xtreme light Punch Through) results in:
 - short circuit rated for 10 μ sec.
 - very low gate charge
 - square RBSOA @ 3x I_C
 - low EMI
- Thin wafer technology combined with the XPT design results in a competitive low $V_{CE(sat)}$
- Temperature sense included
- SONIC™ diode
 - fast and soft reverse recovery
 - low operating forward voltage

Application:

- AC motor drives
- Pumps, Fans
- Washing machines
- Air-conditioning system
- Inverter and power supplies

Package:

- E1 package
- Assembly height is 17.1 mm
- Insulated base plate
- Pins suitable for wave soldering and PCB mounting
- UL registered E72873

Output Inverter T1 - T6

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ C$		1200		V
V_{GES}	max. DC gate voltage	continuous		± 20		V
V_{GEM}	max. transient collector gate voltage	transient		± 30		V
I_{C25}	collector current	$T_C = 25^\circ C$	17		A	
I_{C80}		$T_C = 80^\circ C$	12		A	
P_{tot}	total power dissipation	$T_C = 25^\circ C$	65		W	
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 9 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.8 2.1	2.1	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 0.3 mA; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	5.4	5.9	V
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	0.02 0.3	0.15	mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 V$		500	nA	
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 V; V_{GE} = 15 V; I_C = 10 A$	27		nC	
$t_{d(on)}$	turn-on delay time	<div style="display: inline-block; vertical-align: middle; margin-right: 10px;">inductive load $V_{CE} = 600 V; I_C = 10 A$ $V_{GE} = \pm 15 V; R_G = 100 \Omega$</div> $T_{VJ} = 125^\circ C$	70		ns	
t_r	current rise time		40		ns	
$t_{d(off)}$	turn-off delay time		250		ns	
t_f	current fall time		100		ns	
E_{on}	turn-on energy per pulse		1.1		mJ	
E_{off}	turn-off energy per pulse		1.1		mJ	
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 V; R_G = 100 \Omega; V_{CEK} = 1200 V$ $T_{VJ} = 125^\circ C$		30	A	
I_{sc} (SCSOA)	short circuit safe operating area	$V_{CE} = 900 V; V_{GE} = \pm 15 V;$ $R_G = 100 \Omega; t_p = 10 \mu s$; non-repetitive	$T_{VJ} = 125^\circ C$	40		A
R_{thJC}	thermal resistance junction to case	(per IGBT)			2.0	K/W
R_{thCH}	thermal resistance case to heatsink		0.7		K/W	

Output Inverter D1 - D6

Ratings

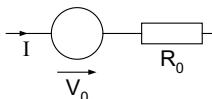
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1200		V
I_{F25}	forward current	$T_C = 25^\circ C$	19		A	
I_{F80}		$T_C = 80^\circ C$	13		A	
V_F	forward voltage	$I_F = 10 A; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.95 1.95	2.2	V
Q_{rr}	reverse recovery charge	<div style="display: inline-block; vertical-align: middle; margin-right: 10px;">$V_R = 600 V$ $di_F/dt = -250 A/\mu s$ $I_F = 10 A; V_{GE} = 0 V$</div> $T_{VJ} = 125^\circ C$	1.3		μC	
I_{RM}	max. reverse recovery current		10.5		A	
t_{rr}	reverse recovery time		350		ns	
E_{rec}	reverse recovery energy		0.35		mJ	
R_{thJC}	thermal resistance junction to case	(per diode)		2.4	K/W	
R_{thCH}	thermal resistance case to heatsink		0.8		K/W	

Module

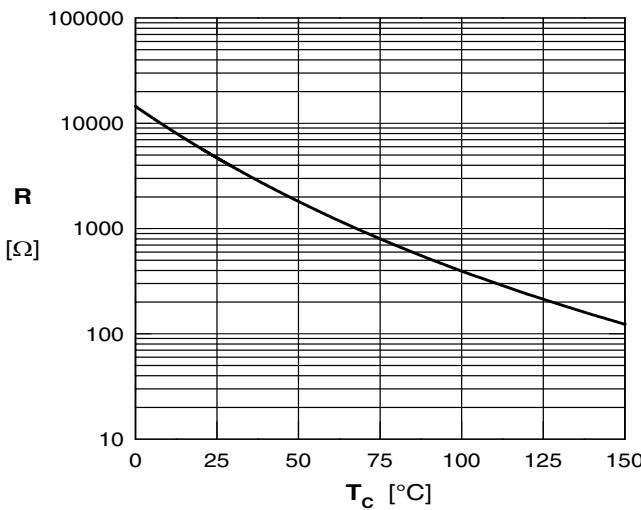
Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
T_{VJ}	<i>operating temperature</i>		-40		125	°C
T_{VJM}	<i>max. virtual junction temperature</i>				150	°C
T_{stg}	<i>storage temperature</i>		-40		125	°C
V_{ISOL}	<i>isolation voltage</i>	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			2500	V~
CTI	<i>comparative tracking index</i>				-	
F_c	<i>mounting force</i>		40		80	N
d_s	<i>creep distance on surface</i>			12.7		mm
d_A	<i>strike distance through air</i>			12.7		mm
Weight				40		g

Temperature Sensor NTC

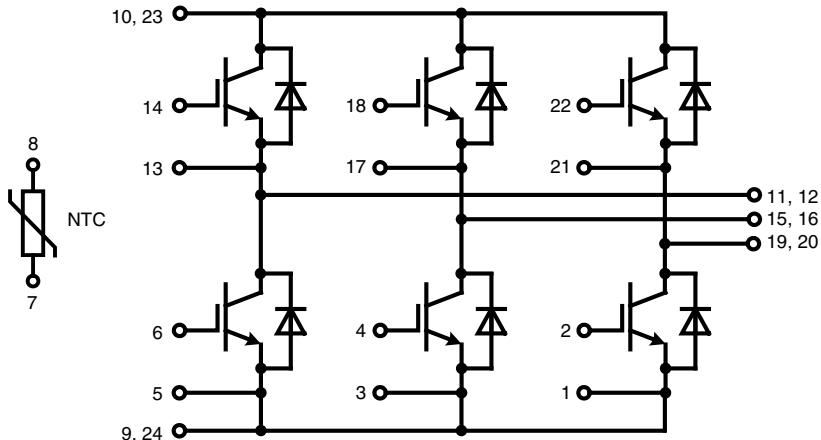
Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	<i>resistance</i>			$T_c = 25^\circ\text{C}$	4.75	5.0
$B_{25/50}$					3375	K

Equivalent Circuits for Simulation**Ratings**

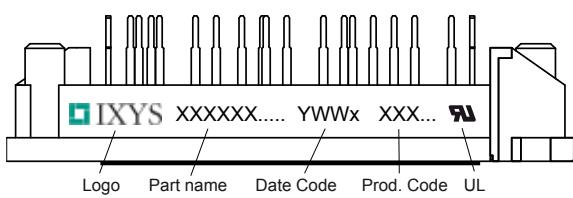
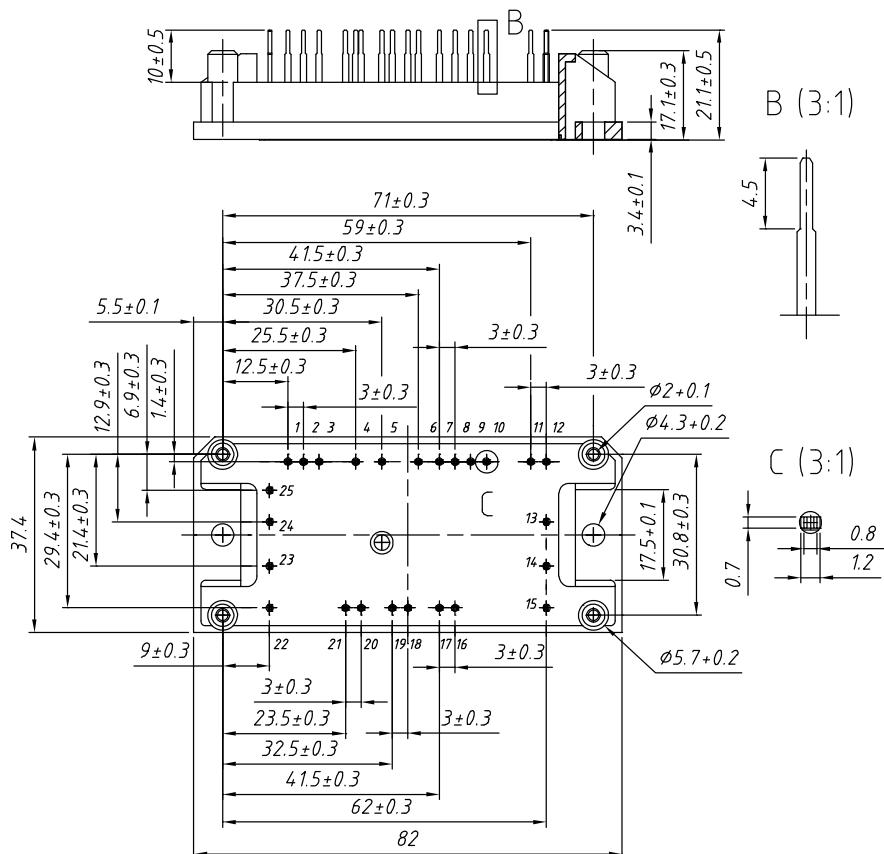
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_0	<i>IGBT</i>				1.1	V
R_0					153	$\text{m}\Omega$
V_0	<i>Diode</i>				1.25	V
R_0					85	$\text{m}\Omega$



Typ. NTC resistance versus temperature

Circuit Diagram**Outline Drawing**

Dimensions in mm (1 mm = 0.0394“)

**Part number**

M = Module
 I = IGBT
 X = XPT
 A = standard
 10 = Current Rating [A]
 W = 6-Pack
 1200 = Reverse Voltage [V]
 T = NTC
 ML = E1-Pack

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXA 10 W 1200 TML	MIXA10W1200TML	Box	10	510155

IXYS reserves the right to change limits, test conditions and dimensions.

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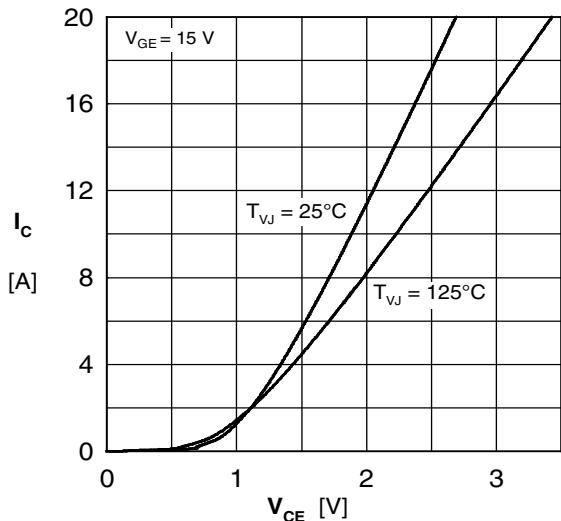
IGBT T1 - T6


Fig. 1 Typ. output characteristics

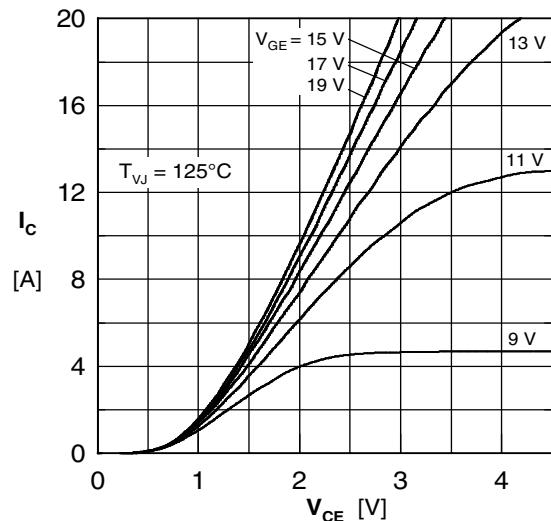


Fig. 2 Typ. output characteristics

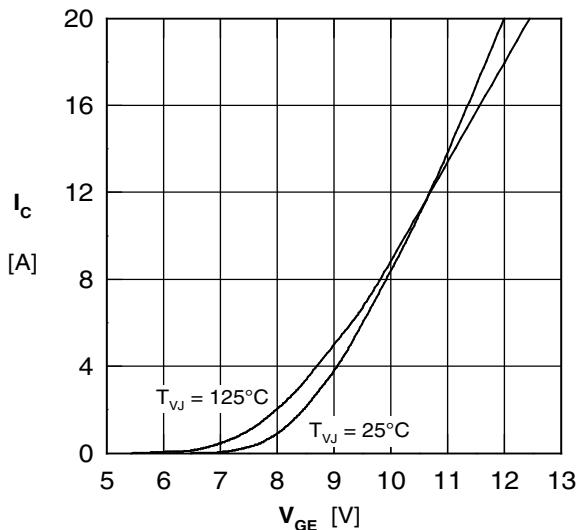


Fig. 3 Typ. tranfer characteristics

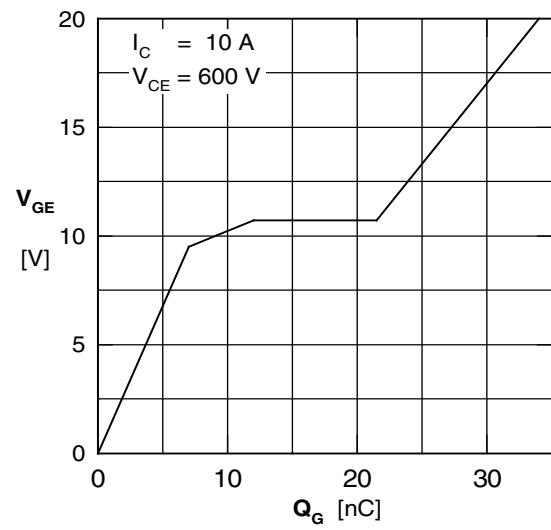


Fig. 4 Typ. turn-on gate charge

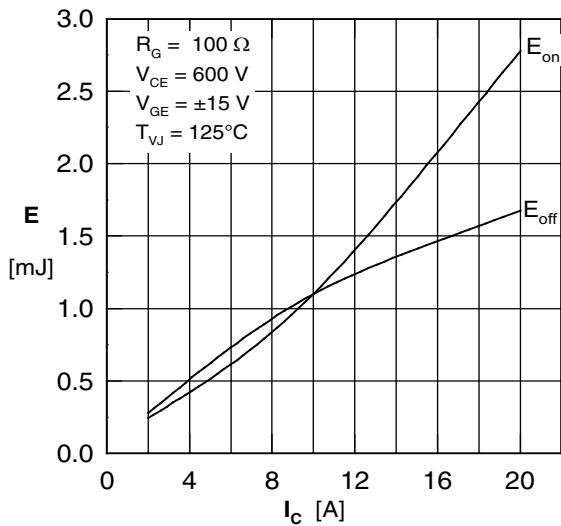


Fig. 5 Typ. switching energy vs. collector current

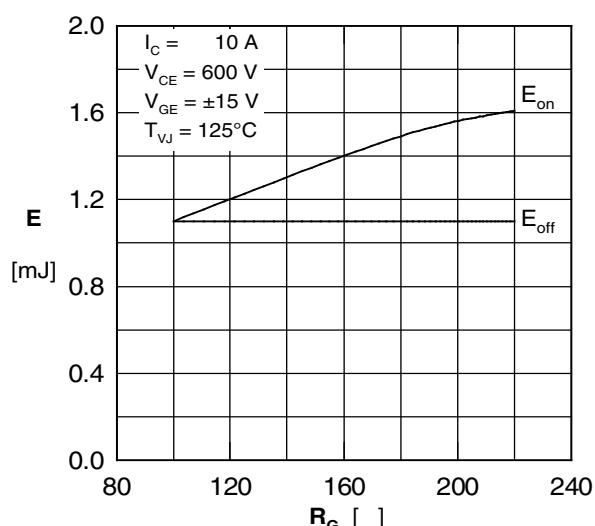


Fig. 6 Typ. switching energy vs. gate resistance

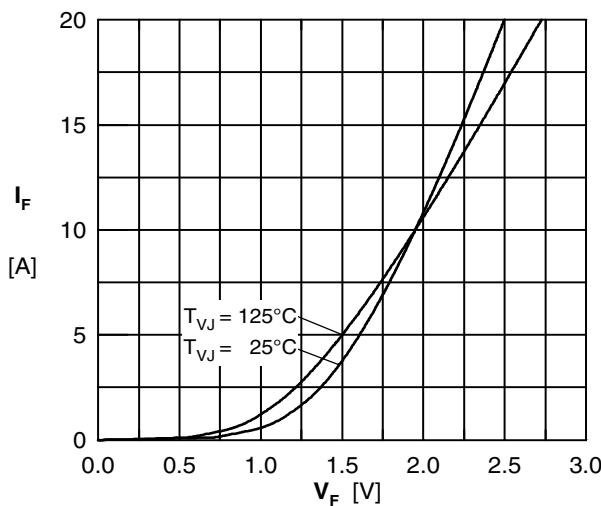
Diode D1 - D6


Fig. 7 Typ. forward characteristics

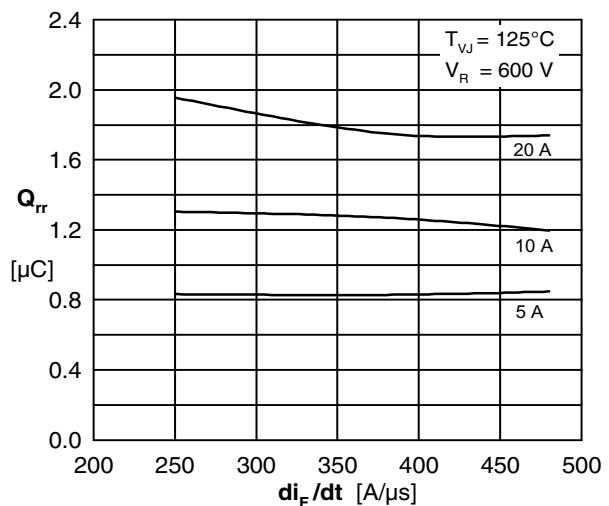
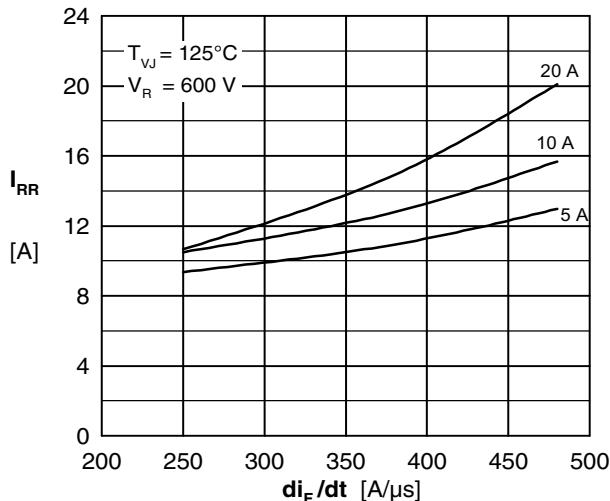
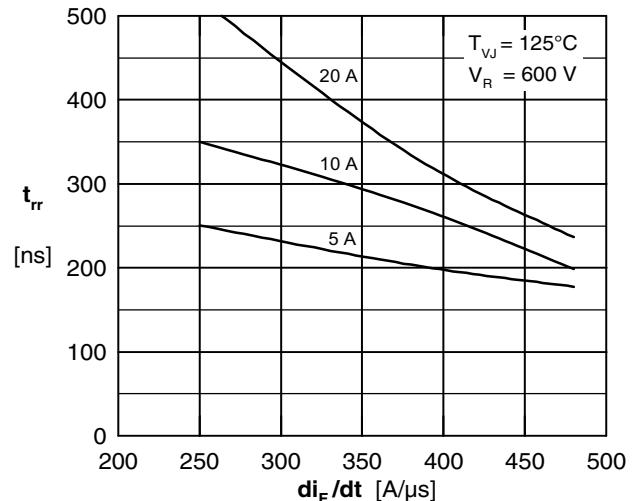
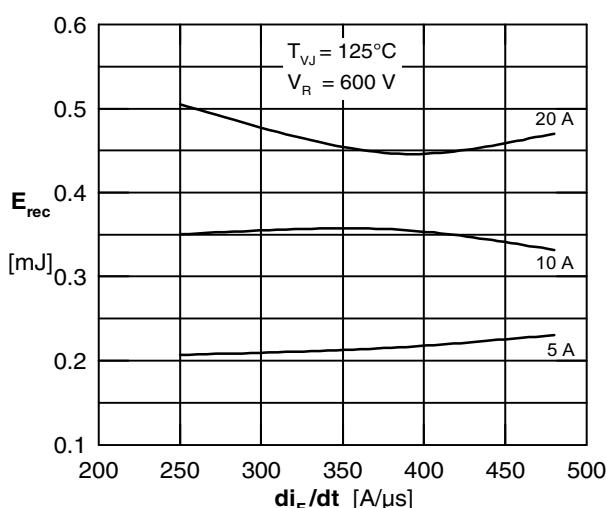
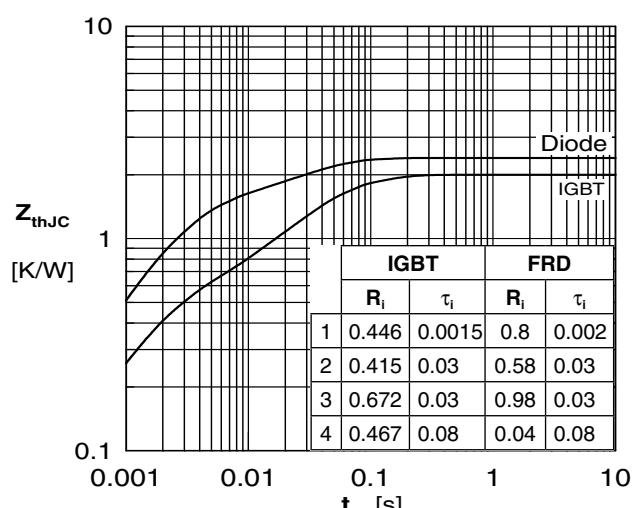

 Fig. 8 Typical reverse recovery charge Q_{rr} versus. di_F/dt (125°C)

 Fig. 9 Typical peak reverse current I_{rr} versus di_F/dt (125°C)

 Fig. 10 Typ. recovery time t_{rr} vs. di/dt (125°C)

 Fig. 11 Typ. recovery energy E_{rec} vs. di_F/dt (125°C)


Fig. 12 Transient thermal impedance

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